## Application/Control No. Applicant(s)/Patent Under-Reexamination LEMAN, MICHAEL V. Examiner Alexander Eisen Applicant(s)/Patent Under-Reexamination LEMAN, MICHAEL V. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,343,006	01-2002	Moscovitch et al.	361/681
	В	US-			
	ပ	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 05-197444	08-1993	JAPAN	HITACHI	G09G 3/20
	0	JP 02-129689	05-1990	JAPAN	MITSUBISHI	G09F 9/00
	Р	JP 06-161636	06-1994	JAPAN	MATSUSHITA	G06F 3/03
	Q	JP 05-061635	03-1993	JAPAN	HITACHI	G09F 9/00
	R	WO 99/31649	06-1999	WIPO	COMOLATI	G09G 3/36
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	w						
	x						

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